

DESCRIPTION OF REQUEST

1. Introduction

By the instant application, BAE Systems Information and Electronic Systems Integration Inc. ("BAE Systems") requests that the Commission grant a two year experimental license to permit BAE Systems to operate the facilities (the "Facilities") specified in the instant Form 442.

The instant application seeks a two year license for the same facilities that were granted under Special Temporary Authority ("STA") pursuant to File No. 0391-EX-ST-2005, and under the same terms and conditions.

2. Purpose of the Operation

BAE Systems Information & Electronic Warfare Systems (IEWS), a business unit of the Information and Electronic Systems Integration Sector (IESI) within BAE Systems, Inc., will conduct the testing specified in this STA Request. IEWS is a major producer of electronic warfare systems, protection systems, and tactical surveillance and intelligence systems for all branches of the armed forces. IEWS' lines of business include Electronic Warfare/Electronic Protection, Electronic Warfare/Information Warfare, Integrated Defense Solutions, and Mission Electronics with products and services spanning the whole electromagnetic spectrum.

The testing at the Litchfield Antenna Test Range is a critical part of the manufacture and delivery of military systems provided to the Armed Forces in support of Homeland Security as well as war efforts. As a general matter, the purpose of the facilities for which consent is requested herein is to measure individually the performance of full scale model antennas of various types (i.e., loop, monopole, dipole), and measure the performance of the antennas on a large ground plane, in connection with an Airborne Antenna Testing program. The contract number associated with the subject program is as follows:

Contract No.: F33657-03-G-3027

The relevant agency and Point-of-Contact for the above-referenced contract will be submitted by BAE Systems to the Commission's Security Office, under applicable submission procedures

In addition, by e-mail dated December 8, 2005, BAE Systems advised the Commission that certain of the facilities previously granted by STA under File No. 0391-EX-ST-2005 are being operated in connection with a Classified Contract submitted to the Commission's Security Office in connection with File No. 0705-EX-ST-2005. Accordingly, the same overlapping facilities associated with the Classified Contract under File No. 0705-EX-ST-2005 will continue to be operated under the facilities granted pursuant to this application.

3. Other Issues

A. Requested Area of Operation

The Litchfield Antenna Test Range is comprised of multiple separate testing locations on the BAE Systems campus at which the subject experiment may be conducted. In addition, depending on the particular requirements of the experiment (i.e., when generating signals at zero degree elevation), it may be necessary to move a given antenna along the bore site line on the range up to a distance of 100 feet. ***Accordingly, in order to accommodate these requirements, BAE Systems is requesting authority to operate all of the specified facilities within a 1,500 foot radius from the centerpoint geographic coordinates identified in the application*** (i.e., 42-48-22 N.Lat.; 071-25-33 W.Long. [NAD 83]).

Commission approval of such area of operation will provide BAE Systems with the flexibility it requires to move the specified test equipment to any appropriate testing location on the Litchfield Antenna Test Range during the authorized term of operation, in response to the requirements of the experiment.

B. Information Regarding Non-Directional (Omni-directional) Antenna (all below 6m)

Manufacturer	Model #	Quantity	Gain (Nominal)	3dB BW E (Vertical)	3dB BW H (Horizontal)
Sanders	TASES 24	2	-31.5 to +1.1 dBi	OMNI	N/A
Sanders	1/4Mon	4	-5.2 dBi	OMNI	N/A
Sanders	TASES 36	2	-60 to -5dBi	OMNI	N/A
Sanders	TASES 12	2	-10 to -5	OMNI	N/A
Sanders	Slant	1	-20 to -5	OMNI	N/A

C. Directional Antennas (all below 6m)

Manufacturer	Model #	Quantity	Gain (Nominal)	3dB BW E (Vertical)	3dB BW H (Horizontal)
SA	26-0.1	1	+8 dBi	60°	120°
SA	29-0.1	2	+8 dBi	60°	120°
SA	27-1.0/8	1	+8 dBi	9°	1.5°
SA	28-1.0/8/10	1	+8 dBi	9°	4.5°
Sanders	1/2 Horn	1	+8 dBi	60-30°	N/A
Sanders	Dual Horn	1	+8 dBi	60-30°	60-30°
Sanders	1/2 Horn	1	+8 dBi	60-45°	N/A
Condor	AS-48461	1	+5-18 dBi	60-10°	60-10°
AEL	H-1498	1	+8-12 dBi	60-30°	60-30°
SA	28-2.0/8/10	1	+8 dBi	60-30°	60-30°

D. Note Regarding Output Power/ERP Figures

For the purpose of completion of the attached form, antenna efficiency has been assumed to be 100%. Therefore, the transmitter power and the radiated power are reported as equal (i.e., both the Output Power and the ERP are reported as “.007 W”). In practice the antenna efficiency and cable loss between the transmitter and the antenna will be considered and the transmitter power adjusted to achieve the approved output radiated power level.

E. Note Regarding “Mean” Power Designation

In the attached form, the power levels are reported as a “Mean” value. The transmitter will not be left on continuously due to the nature of the experiment and the need to physically reposition the unit under test between measurements, cycle through frequencies, change elevation angles of the transmit antenna, etc. where the transmit power is reduced to zero. The actual duty cycle of the transmit system is approximately 7%. Mean power is therefore a more accurate representation of the applicant’s proposed activity.

F. Transmitting Equipment

The following information is provided with respect to the transmitting equipment to be involved in the experiment. It is noted that each of these transmitters is non-experimental in nature:

Manufacturer	Model	Quantity
HP	HP8753D	2
HP	HP8753E	2
HP	HP8753A	2
HP	HP8510B	1
HP	HP8510C	1
HP	HP8340B	1
HP	HP8341	1
HP	HP8643A	1

G. Additional Signal Amplification

Due to the low gain of the transmit antennas, an additional signal amplification may be utilized as follows:

Power Amplifiers	Model	Frequency Band	Power Output	Quantity
ENI	510L	1.7MHz to 500MHz	9.5W	2
OPHIR	5069	.5MHz to 500MHz	8W	1
OPHIR	5094	1MHz to 1000MHz	3W	1
OPHIR	5160	.8GHz to 4.2GHz	7W	1
ENI	603L	.8 MHz to 1000MHz	3W	1

H. Acceptance of Special Conditions Previously Imposed for the STA

When the Commission granted the STA under File No. 0391-EX-ST-2005, several Special Conditions were imposed. BAE Systems hereby confirms that it is willing to accept the imposition of the same Special Conditions in connection a grant of the instant application, including the following Special Conditions:

- “(1) No transmissions are allowed on the following frequencies including plus or minus 6 kHz: 243 MHz, 345 MHz and 401 MHz.
- (2) No transmissions are allowed on the following frequencies including plus or minus 8 kHz: 165.7625 MHz, 169.3 MHz, 169.3125 MHz, 169.325 MHz, 172.9 MHz and 172.925 MHz.
- (3) No transmission on the frequency 34.83 MHz plus or minus 8 kHz when operating 9.5 watt amplifier.
- (4) No emissions are permitted within +/- 25 kHz of the following frequencies (all in MHz): 228.900; 239.025; 243.000; 254.250; 255.400; 260.900; 263.050; 263.100; 269.300; 273.450; 277.400; 279.600; 282.200; 284.750; 307.900; 338.200; 341.700; 343.600; 348.700; 353.700; 354.100; 360.600; 364.200; 370.000; 381.400; 381.650; 382.000; 385.450
- (5) No emissions are permitted within +/- 25 kHz of the following frequencies (all in MHz): 120.275; 120.600; 121.300; 121.500; 121.800; 122.200; 122.300; 123.750; 124.100; 124.400; 124.600; 124.900; 125.050; 125.100; 125.825; 125.950; 126.500; 126.750; 127.200; 127.350; 128.200; 128.325; 128.400”

I. Prevention of Interference

BAE SYSTEMS hereby advises the Commission that the tests to be conducted under the requested Commission authorization are to be conducted solely on the campus of BAE SYSTEMS’ Litchfield, New Hampshire facilities. Such location will result in the separation of the test facilities from other existing transmit or receive facilities. BAE SYSTEMS’ Richard C. Ball will be personally conducting the test and will be available by wireless telephone at (603) 318-6913. Mr. Ball will act as a “stop buzzer” if any issues regarding interference arise during testing.